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- 3) Limit the results by selecting Search Options.
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<pre>(impuls* <near 2=""> respons*)</near></pre>	
<and> (coherent* <near 2=""></near></and>	
averag*)	1
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Note: This function returns plural and suffixed forms of the keyword(s).

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((channel* <near/3> select*) <sentence> power*) <and> *cdma

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